

<b>Notice of References Cited</b>	Application/Control No. 10/519,720		Applicant(s)/Patent Under Reexamination HOSOKAWA ET AL.	
	Examiner Tram H. Nguyen		Art Unit 2818	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Yourdshahyan et al. "Theoretical Structure Determination of a Complex Material: k-Al <sub>2</sub> O <sub>3</sub> ) Department of Applied Physics, Experimental Physics, and Enviromental Inorganic Chemistry, Chalmers University of Technology and Goteborg University, SE-41296 Goteborg Sweden
	V	Bach et al. "Determination of Ionization Potentials of Aluminum Oxides via Charge Transfer" Chemistry Division/Code 6110, Navel Research Laboratory, Washington DC 20375-5000 (Received: April 24, 1991; In Final Form: May 30, 1991)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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